PDS Spectral Library Data Dictionary User's Guide

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1 Introduction

1.1 Purpose of this User's Guide

This guide describes the organization and contents of the Spectral Library Data Dictionary, one of several Discipline Dictionaries maintained by the Planetary Data System (PDS). This dictionary is used when creating PDS labels for laboratory spectral data. It contains terms that describe laboratory spectral measurements and the specimens measured.

1.2 Audience

This guide is intended for users and data providers of Spectral Library data products. In particular, users may wish to refer to Section 5, Definitions, to better understand the terms in the PDS labels of data products. Data providers may want to read the entire guide to understand how to create PDS labels for their spectral data.

1.3 Applicable Documents

PDS4 Concepts, https://pds.nasa.gov/datastandards/documents/concepts/, a high-level view of the PDS4 archiving standard

The Planetary Data System Standards Reference,

https://pds.nasa.gov/datastandards/documents/sr/current/, the complete reference for the PDS4 Information Model

The PDS4 Data Dictionary, https://pds.nasa.gov/datastandards/documents/dd/current/, the PDS4 core (or "common") dictionary in an easily searchable HTML format

Data Providers' Handbook: Guide to Archiving Planetary Data Using the PDS4 Standard,

https://pds.nasa.gov/datastandards/documents/dph/current/, a step-by-step guide for creating a PDS archive

The PDS4 Information Model Specification,

https://pds.nasa.gov/datastandards/documents/im/current/, the same information as in the PDS4 core dictionary, in a formal specification for use by programmers and data engineers

2 Overview of the Spectral Library Data Dictionary

A spectral library is a collection of spectral measurements of laboratory samples, also known as specimens. Specimens may be rocks, minerals, ice, meteorites, etc. They may be in various physical forms. They may be naturally-occurring or synthetic. A given specimen may have many measurements. The measurements may consist of reflectance spectra, Raman spectra, XRD, XRF, LIBS, and other types.

In the PDS Spectral Library, each measurement's data is contained in a single file and is accompanied by a PDS4 label that describes the measurement and the specimen that was measured. Together the data file and PDS4 label are considered one data product.

The Spectral Library Data Dictionary is maintained by Daniel Scholes at the PDS Geosciences Node. It may be revised when new spectra are submitted to the library. Questions about it may be addressed to geosci@wunder.wustl.edu.

3 How to Include the Spectral Library Dictionary in a PDS4 Label

PDS4 labels are written in XML (https://www.w3.org/XML/) and are governed by the PDS4 XML schema that defines the label structure and contents. The XML schema not only defines the individual attributes in the label, but also defines the order in which they appear in the label. The main PDS4 XML schema may be supplemented with additional, specialized schemas as needed for particular applications. The Spectral Library Data Dictionary is one such specialized schema.

The schema that defines the main, or "core", PDS4 Dictionary is available at https://pds.nasa.gov/datastandards/schema/released/#pds. The schema that defines the Spectral Library Data Dictionary is at https://pds.nasa.gov/datastandards/schema/released/#speclib. Here you will see that a dictionary is made up of several files, but only these two are needed for reference in a Spectral Library product label:

PDS4_SPECLIB_xxxx_yyyy.xsd	The schema file itself, containing dictionary definitions. Like PDS	
	labels, the schema file is written in XML. xxxx is the version number of	
	the PDS Core Dictionary and yyyy is the version number of the	
	Spectral Library Data Dictionary.	
PDS4_SPECLIB_xxxx_yyyy.sch	The Schematron file, containing rules about the use of dictionary	
	terms, also in XML	

The Spectral Library dictionary files are referenced at the beginning of a data product label, as shown in red in this example:

The Spectral Library Data Dictionary defines the metadata terms that describe the data products in the Spectral Library. In a PDS4 data dictionary individual elements are called attributes, and groups of

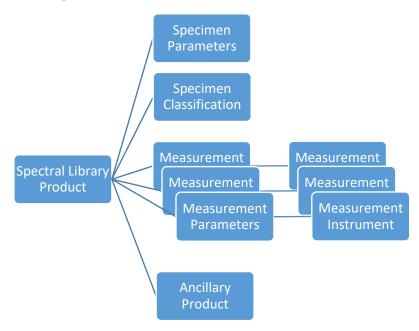
associated attributes are called classes. A class may contain other classes, known as subclasses. The Spectral Library Data Dictionary, referred to in PDS4 labels as "speclib", consists of the top-level Spectral_Library_Product class and four subclasses: Specimen_Parameters, Specimen_Classification, Measurement_Parameters, and Ancillary_Product. The Measurement_Parameters subclass itself has a subclass, Measurement_Instrument. This top level class and its subclasses belong in the Discipline_Area section of a PDS4 label. For examples of labels of actual products, see section 6.

4 Organization of Classes and Attributes

This section shows the organization of Spectral Library classes and attributes in the order in which they are required to appear in the label. Section 5 lists the attributes and their complete definitions in alphabetical order.

4.1 Class < speclib: Spectral Library Product>

Spectral_Library_Product is the superclass that encompasses all other Spectral Library classes and attributes. It has the following structure.



Hierarchy of classes in the Spectral Library Product superclass

This structure is expressed in the label as shown below. Note that the **Spectral_Library_Product** class includes two attributes that are not in a subclass: **processing_description** and **measurement_segments**. It is possible for a spectral measurement to be made up of multiple spectra measured by different instruments. The attribute **processing_description** explains this set of measurements for a given spectrum. The attribute **measurement_segments** gives the number of individual spectra that were combined to create a final merged spectrum. If the spectrum is not merged from multiple segments, then the value of measurement_segments is 1. For each segment, a separate instance of the **Measurement_Parameters** class is provided.

```
<speclib:Spectral Library Product>
  <speclib:processing_description>
      [processing description text]
  </speclib:processing description>
  <speclib:Specimen Parameters>
      [Specimen Parameters attributes]
  </speclib:Specimen_Parameters>
  <speclib:Specimen_Classification>
      [Specimen Classification attributes]
  </speclib:Specimen Classification>
  <speclib:measurement segments>2</speclib:measurement segments>
  <speclib:Measurement Parameters>
      [Measurement_Parameters attributes for the first segment]
  </speclib:Measurement_Parameters>
  <speclib:Measurement Parameters>
      [Measurement Parameters attributes for the second segment]
  </speclib:Measurement Parameters>
  <speclib:Ancillary Product>
      [Ancillary_Product attributes]
  </speclib:Ancillary_Product>
</speclib:Spectral Library Product>
```

The four classes **Specimen_Parameters**, **Specimen_Classification**, **Measurement_Parameters**, and **Ancillary_Product** are described in the sections that follow. The **Ancillary_Product** section is optional; all others are required, and they must appear in the order shown.

The table below describes each component of the **Spectral_Library_Product** class. Asterisks (*) indicate required components. More complete definitions are in Section 5. Throughout this document class names are given with each word capitalized and attribute names are given in all lowercase, following PDS custom.

Spectral_Library_Product Class	
Component	Description
processing_description	The processing_description attribute provides information about
	how measurement(s) for a particular data product were made, in
	addition to the information given in the Measurement_
	Parameters class. In the case of a product created by merging
	multiple measurements, this attribute describes how the merge
	was done. The description can be as long as necessary.
*Specimen_Parameters Class	The Specimen_Parameters class provides information that
	describes the specimen (sample) that was analyzed, such as
	particle size, collection location, and specimen owner. The class
	can appear only once in the label.
*Specimen_Classification Class	The Specimen_Classification class classifies the specimen as to its
	composition and physical state. The class can appear only once in
	the label.
*measurement_segments	The measurement_segments attribute gives the number of
	individual spectra that were combined to create the final merged
	spectrum. If the spectrum is not merged from multiple segments,
	then the value of measurement_segments is 1. There will be one
	instance of the Measurement_Parameters class for each
	segment.

*Measurement_Parameters Class	The Measurement_Parameters class contains attributes that
	describe the conditions under which a spectral measurement was
	made. There will be one instance of the
	Measurement_Parameters class for each segment of the
	spectrum.
Ancillary_Product Class	The Ancillary_Product class points to an ancillary data product
	that contains additional data about the specimen (for example,
	an XRD measurement or an image of the specimen). This class can
	appear more than once, or may not appear at all.

4.2 Class < speclib: Specimen Parameters >

The **Specimen_Parameters** class identifies and describes the laboratory specimen that is the target of the spectral measurement.

The class is expressed in the label as shown below. This class has no subclasses.

```
<speclib:Spectral Library Product>
  <speclib:Specimen Parameters>
     <speclib:specimen id>
          [identifier unique within the Spectral Library]
     </speclib:specimen id>
      <speclib:specimen name>[common name]</speclib:specimen name>
     <speclib:specimen_description>
          [specimen description]
      </speclib:specimen description>
      <speclib:source specimen id>
          [identifier of source specimen from which this one was derived]
      </speclib:source specimen id>
      <speclib:specimen min size unit="micrometer">
          [minimum size]
      </speclib:specimen min size>
      <speclib:specimen max size unit="micrometer">
          [maximum size]
      </speclib:specimen max size>
      <speclib:specimen collection location>
          [location where specimen was collected]
      </speclib:specimen collection location>
      <speclib:specimen owner location>
          [facility that owns the specimen]
      </speclib:specimen owner location>
      <speclib:specimen owner name>
          [name of specimen owner]
      </speclib:specimen owner name>
  </speclib:Specimen Parameters>
</speclib:Spectral Library Product>
```

The table below describes the components of the **Specimen_Parameters** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Specimen_Parameters Class	
Component	Description

*specimen_id	The specimen_id attribute uniquely identifies the
_	specimen within the Spectral Library.
specimen_name	The specimen_name attribute provides a name or
	identifier for the specimen. The value is typically assigned
	by the person who owns the specimen or the person who
	made the measurement, and is not guaranteed to be
	unique. There are no formation rules or constraints on the
	value, only that the name has to be less than 255
	characters long.
specimen_description	The specimen_description attribute provides a short
	description of the specimen up to 300 characters long.
source_specimen_id	The source_specimen_id attribute identifies the source
	specimen from which the observed specimen is derived.
specimen_min_size	The specimen_min_size attribute identifies the minimum
	particle size of the observed specimen. Units are specified
	with the 'unit' XML attribute. Allowable units are 'AU',
	'Angstrom', 'cm', 'km', 'm', 'micrometer', 'mm', and 'nm'.
specimen_min_size_reported_percentile	The specimen_min_size_reported_percentile identifies
	the percentile reported by the specimen_min_size
	element. For example, a
	specimen_min_size_reported_percentile of 90 indicates
	that 90 percent of the specimen has a particle size greater
	than or equal to specimen_min_size. The value is
	optional, and it is always reported with a specified unit id
	of 'percent'.
specimen_max_size	The specimen_max_size attribute identifies the maximum
	particle size of the observed specimen. Units are specified
	with the 'unit' XML attribute. Allowable units are 'AU',
	'Angstrom', 'cm', 'km', 'm', 'micrometer', 'mm', and 'nm'.
specimen_max_size_reported_percentile	The specimen_max_size_reported_percentile identifies
	the percentile reported by the specimen_max_size
	element. For example, a
	specimen_max_size_reported_percentile of 90 indicates
	that 90 percent of the specimen has a particle size less
	than or equal to specimen_max_size. The value is
	optional, and it is always reported with a specified unit id
	of 'percent'.
*specimen_collection_location	The specimen_collection_location attribute provides the
	place where the specimen was collected. The attribute
	may be present but with a null value.
*specimen_owner_location	The specimen_owner_location attribute provides the
	institution or facility that owns the specimen at the time
	the measurement is taken. Use the value 'Unknown' if the
	location is not known.
*specimen_owner_name	The specimen_owner_name attribute identifies the
	individual or laboratory that owns the specimen at the

	time the measurement is taken. Use the value 'Unknown'
	if the owner is not known.
specimen_provider_name	The specimen_provider_name attribute provides the
	name of the person who provided the specimen for
	spectral measurement. This could be different from the
	specimen_owner_name (individual or laboratory).
specimen_thin_section_flag	The specimen_thin_section_flag element indicates
	whether or not the specimen is a thin section.

4.3 Class < speclib: Specimen Classification >

The Specimen_Classification class provides information about the type of the specimen that is the target of the spectral measurement.

The class is expressed in the label as shown below. This class has no subclasses.

```
<speclib:Spectral Library Product>
  <speclib:Specimen Classification>
     <speclib:specimen type>
         [identifier of the origin of specimen]
     </speclib:specimen type>
      <speclib:material common name>
          [a name useful for searching]
     </speclib:material common name>
      <speclib:material origin>[Natural, Synthetic, or Natural-Doped]
      </speclib:material origin>
     <speclib:synthetic type>
          [required if material_origin is synthetic]
      </speclib:synthetic_type>
      <speclib:material state>[Solid, Liquid, or Gas]/speclib:material state>
      <speclib:organic type>
          [Inorganic, Organic, or Mixture]
      </speclib:organic type>
      <speclib:material_type>[general type of specimen]</speclib:material type>
      <speclib:material subtype>
          [more specific material subtype]
      </speclib:material subtype>
      <speclib:mineral type>
          [required if material type is Mineral]
      </speclib:mineral_type>
      <speclib:mineral_subtype>
          [more specific mineral subtype]
      </speclib:mineral subtype>
      <speclib:rock type>
          [required if material type is Rock]
      </speclib:rock type>
      <speclib:rock_subtype>
          [more specific rock subtype]
     </speclib:rock subtype>
      <speclib:volatile type>[Poor, Rich, or Unknown]
      <speclib:synthetic processing description>
          [descriptive text]
      </speclib:synthetic_processing_description>
  </speclib:Specimen Classification>
```

The table below describes the components of the **Specimen_Classification** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Specimen_Classification Class	
Component	Description
*specimen_type	The specimen_type attribute gives one or two terms that classify the origin of the specimen. Allowable values are 'Terrestrial Sample', 'Lunar Meteorite', 'Mars Meteorite', 'Other Meteorite', 'Returned Lunar Sample', 'Returned Asteroid Sample', and 'Synthetic Sample'. The most common combination of two specimen_types would include synthetic sample for naturally occuring specimen that have been significantly modified. Other values may be added to the dictionary as needed.
material_common_name	The material_common_name attribute gives a specific name of the specimen material that would be useful for searching in a database.
*material_origin	The material_origin attribute specifies whether the specimen is a natural, synthetic material, or natural/doped. The allowable values are 'Natural', 'Synthetic', and 'Natural-Doped'.
synthetic_type (required if material_origin = Synthetic)	The synthetic_type attribute identifies the nature of a synthetic specimen. Possible values are 'Entirely Synthetic', 'Natural and Synthetic', 'From Natural', and 'Hardware'.
*material_state	The material_state attribute identifies the physical state of the specimen. Allowable values are 'Solid', 'Liquid', and 'Gas'.
organic_type	The organic_type attribute identifies the organic type to which the specimen belongs. Allowable values are 'Inorganic', 'Organic', and 'Mixture'.
*material_type	The material_type attribute indicates the general type of the specimen. See the definition in Section 5 for the list of allowed values.
material_subtype	The material_subtype attribute provides an optional descriptor for additional information about the physical state of the specimen, e.g. particulate or nonparticulate. This attribute can appear more than once.
mineral_type (required if material_type = Mineral)	The mineral_type attribute indicates the mineral class for the specimen. See the definition in Section 5 for the list of allowed values. This attribute can appear more than once in the case of a mixture of minerals.
mineral_subtype (optional; allowed if material_type = Mineral)	The mineral_subtype attribute provides for further subdividing the mineral classification. For example, the value could be 'Smectite' if the mineral_type is 'Phyllosilicate'. There is no enumerated list for this attribute. It can appear more than once.

rock_type (required if material_type = Rock)	The rock_type attribute indicates the rock type for the specimen. Possible values are 'Igneous', 'Sedimentary', and 'Metamorphic'.
rock_subtype	The rock_subtype attribute provides for further subdividing
(optional; allowed if material_type =	the rock type. For example, the value could be 'Sandstone' if
Rock)	the rock_type is 'Sedimentary'. There is no enumerated list
	for this attribute. It can appear more than once.
volatile_type	The volatile_type attribute indicates whether the material is volatile-poor (less than 2.0% loss on ignition) or volatile-rich (greater than 2.0% loss on ignition). Possible values are 'Poor',
	'Rich', and 'Unknown'.
synthetic_processing_description	The synthetic_processing_description attribute describes how a synthetic specimen was generated. The description can
	be up to 255 characters long.
specimen_ph	The specimen_ph element provides the pH of the observed
	specimen.
specimen_dilution_method	The specimen_dilution_method element describes the
	method by which dilution was conducted.
specimen_solute_standard	The specimen_solute_standard element provides the
	standard used for the solute.

The following rules apply to the use of the **Specimen_Classification** class.

Rule	Description
speclib_classification_rule_solid_material	If material_state is Solid, then the attributes
	material_type and material_subtype must be
	present, and material_subtype must include
	either Particulate or Nonparticulate.
speclib:classification_rule_organic_material	If material_type is Organic, then the attribute
	organic_type must also be Organic.
speclib_classification_rule_mineral	If material_type is Mineral, then the attribute
	mineral_type must be present.
speclib_classification_rule_rock	If material_type is Rock, then the attribute
	rock_type must be present.
speclib_classification_rule_material_subtype	If the attribute material_subtype is present, then
	the attribute material_type must also be present.
speclib_classification_rule_mineral_subtype	If the attribute mineral_subtype is present, then
	the attribute mineral_type must also be present.
speclib_classification_rule_rock_subtype	If the attribute rock_subtype is present, then the
	attribute rock_type must also be present.
speclib_classification_rule_synthetic	If material_origin is Synthetic, then the attribute
	synthetic_type must be present. If
	material_origin is not Synthetic, then the
	attribute synthetic type must not be present.

4.4 Class <speclib:Measurement_Parameters>

The Measurement_Parameters class provides information about the characteristics of the measurement. It includes the subclass Measurement_Instrument, which identifies the instrument used to make the measurement. A spectral measurement may be comprised of multiple spectra measured by different instruments. The attribute measurement_segments in the Spectral_Library_Product superclass gives the number of individual spectra that were combined to create the final merged spectrum. There is one instance of the Measurement_Parameters class for each measured spectrum used to create the labeled PDS product. It is most common to have only one Measurement_Parameters class.

The class is expressed in the label as shown below. This class has one subclass, **Measurement_Instrument**.

```
<speclib:Spectral Library Product>
   <speclib:Measurement Parameters>
      <speclib:segment number>[which segment this is]/speclib:segment number>
      <speclib:Measurement Instrument>
          <speclib:instrument name>[name]</speclib:instrument name>
          <Internal Reference>
             <lid reference>[Instrument LID] </lid reference>
             <reference type>is instrument</reference type>
          </Internal Reference>
      </speclib:Measurement Instrument>
      <speclib:measurement type>[e.g., Reflectance]/speclib:measurement type>
      <speclib:spectral range parameter name>
          [e.g., Wavelength]
      </speclib:spectral range parameter name>
      <speclib:spectral range min>[minimum]</speclib:spectral range min>
      <speclib:spectral range max>[maximum]</speclib:spectral range max>
      <speclib:spectral range unit name>[e.g., nm]
      </speclib:spectral range unit name>
      <speclib:spectral sampling interval min>
          [minimum]
      </speclib:spectral sampling interval min>
      <speclib:spectral sampling interval max>
          [maximum]
      </speclib:spectral sampling interval max>
      <speclib:spectral sampling interval unit>
      </speclib:spectral sampling interval unit>
      <speclib:spectral resolution width min>
          [minimum]
      </speclib:spectral resolution width min>
      <speclib:spectral resolution width max>
          [maximum]
      </speclib:spectral resolution width max>
      <speclib:spectral resolution width unit>
          [unit]
      </speclib:spectral resolution width unit>
      <speclib:measurement reference standard>
      </speclib:measurement reference_standard>
      <speclib:measurement geometry type>
          [e.g., Bidirectional]
```

```
</speclib:measurement geometry type>
      <speclib:incidence_angle unit="deg">[value]</speclib:incidence_angle>
      <speclib:emission angle unit="deg">[value]</speclib:emission angle>
      <speclib:phase angle unit="deg">[value]</speclib:phase angle>
      <speclib:measurement source description>
          [text]
      </speclib:measurement_source_description>
      <speclib:measurement atmosphere pressure>
          [value]
      </speclib:measurement atmosphere pressure>
      <speclib:measurement atmosphere temperature>
      </speclib:measurement atmosphere temperature>
      <speclib:measurement atmosphere relative humidity>
          [value]
      </speclib:measurement atmosphere relative humidity>
      <speclib:measurement atmosphere description>
          [description]
      </speclib:measurement_atmosphere_description>
      <speclib:measurement_date_time>
          [YYYY-MM-DDThh:mm:ss]
      </speclib:measurement date time>
      <speclib:data producer name>
          [who made the measurement? e.g., RELAB]
      </speclib:data producer name>
      <speclib:data_provider_name>
          [who submitted the measurement to the Spectral Library?]
      </speclib:data provider name>
      <speclib:measurement requestor>
          [who requested the measurement?]
      </speclib:measurement_requestor>
      <speclib:measurement notes>
          [text]
      </speclib:measurement notes>
  </speclib:Measurement Parameters>
</speclib:Spectral Library Product>
```

The table below describes the components of the **Measurement_Parameters** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Measurement_Parameters Class	
Component	Description
*segment_number	The segment_number attribute identifies which segment of a merged spectrum is described in this Measurement_Parameters class. The first segment is segment_number 1. If the spectrum is not merged from multiple segments, then the value of segment_number is 1.
*Measurement_Instrument	The Measurement_Instrument class identifies which instrument made the measurement.
*measurement_type	The measurement_type attribute identifies the type of spectroscopy performed on a specimen. See Section 5 for the list of allowed values.

*spectral_range_parameter_name	The spectral_range_parameter_name attribute
	identifies the name of the parameter which
	determines the sampling interval of the
	measurement. See Section 5 for the list of allowed
	values.
*spectral_range_min	The spectral_range_min attribute identifies the
	minimum value at which a given data item was
	sampled. For example, a spectrum that was
	measured in the 0.4 to 3.5 μm range would have a
	spectral_range_min value of 0.4.
*spectral_range_max	The spectral_range_max attribute identifies the
	maximum value at which a given data item was
	sampled. For example, a spectrum that was
	measured in the 0.4 to 3.5 μm range would have a
	spectral_range_max value of 3.5.
*spectral_range_unit_name	The spectral_range_unit_name attribute identifies
	the unit of measure for the values specified by the
	spectral_range_min and spectral_range_max.
spectral_sampling_interval_min	The spectral_sampling_interval_min attribute
	identifies the minimum distance between band
	centers in a given spectrum. If all band centers are
	equally spaced, spectral_sampling_interval_min
	and spectral_sampling_interval_max will have the
	same value.
spectral_sampling_interval_max	The spectral_sampling_interval_max attribute
	identifies the maximum distance between band
	centers in a given spectrum. If all band centers are
	equally spaced, spectral_sampling_interval_min
	and spectral_sampling_interval_max will have the
	same value.
spectral_sampling_interval_unit	The spectral_sampling_interval_unit attribute
1 2 1 62 2	identifies the unit of measure for the values
	specified by spectral_sampling_interval_min and
	spectral_sampling_interval_max.
spectral resolution width min	The spectral_resolution_width_min attribute
	identifies the full width at half minimum (FWHM) of
	a spectral band in a given spectrum. If all bands are
	the same width, spectral_resolution_width_min
	and spectral_resolution_width_max will have the
	same value.
spectral_resolution_width_max	The spectral_resolution_width_max attribute
	identifies the full width at half maximum (FWHM)
	of a spectral band in a given spectrum. If all bands
	are the same width,
	spectral_resolution_width_min and
	spectral_resolution_width_max will have the same
	value.

spectral resolution width unit	The spectral resolution width unit attribute
spectral_resolution_width_unit	The spectral_resolution_width_unit attribute identifies the unit of measure for the values
	specified by spectral_resolution_width_min and
	spectral_resolution_width_max.
measurement_reference_standard	The measurement_reference_standard attribute
	describes the standard object on which
	observations are performed in order to calibrate a
	measurement.
measurement_geometry_type	The measurement_geometry_type attribute
	identifies the type of geometry at which a
	measurement is taken. See Section 5 for the list of
	allowed values.
incidence_angle	The incidence_angle attribute provides the angle
meidence_ungic	between the local vertical at the intercept point
	·
	and a vector from the intercept point to the
	illumination source. The value must be between 0
	and 90 degrees, or the attribute may be present
	with a null value.
emission_angle	The emission_angle attribute provides the angle
	between the local vertical at the intercept point
	and a vector from the intercept point to the
	detector. The value must be between 0 and 90
	degrees, or the attribute may be present with a null
	value.
phase_angle	The phase_angle attribute provides the angle
	between incidence and emission vectors. The value
	must be between 0 and 180 degrees, or the
	attribute may be present with a null value.
maggurament course description	
measurement_source_description	The measurement_source_description attribute
	identifies the source used for the measurement
	such as the type of lamp, heating element, laser, or
	radioactive source.
measurement_atmosphere_pressure	The measurement_atmosphere_pressure attribute
	provides the atmospheric pressure of
	measurement environment. Allowable units for this
	attribute are 'Pa', 'bar', 'hPa', and 'mbar'.
measurement_atmosphere_temperature	The measurement_atmosphere_temperature
	attribute provides the temperature of the
	measurement environment. Allowable units for this
	attribute are 'K' and 'degC'.
measurement_atmosphere_relative_humidity	The measurement_atmosphere_relative_humidity
casarement_aamosphere_relative_namatty	attribute provides the relative humidity of the
	measurement environment. The attribute may be
	present with a null value.
measurement_atmosphere_composition	The measurement_atmosphere_composition
	attribute identifies any gas or gases present in
1	measurement environment.

measurement atmosphere description	The measurement_atmosphere_description
_	attribute describes the atmospheric conditions with
	which the data was taken.
measurement_date_time	The measurement_date_time attribute identifies
	the date and time when the measurement was
	made. The attribute may be present with a null
	value.
*data_producer_name	The data_producer_name element provides the
	name of the creator of the product.
*data_provider_name	The data_provider_name attribute provides the
	full name of the person who submitted the
	measurement to the library.
measurement_requestor	The measurement_requestor attribute provides
	the full name of the person who requested the
	measurement to be made. The attribute may be
	present with a null value. A maximum of two
	names are permitted to allow for potentially a PI
	and student, in case of some RELAB measurements.
microscope_objective	The microscope_objective attribute provides the
	magnification power of the objective lens by power
	(e.g. 4x, 10x).
measurement_notes	The measurement_notes attribute contains
	relevant notes about how a measurement was
	made, up to 1000 characters.
accumulation_time	The accumulation_time is the duration for which a
	measurement was acquired. If more than one
	measurement is reported, this value corresponds to
	the total measurement time across all
	measurements.
dark_subtraction_flag	The dark_subtraction_flag element indicates if a
	spectrum has been dark subtracted. Y or N for yes
	and no are the permissible values.
laser_attenuation	The laser_attenuation element is the energy of the
	laser pulse used for sample ablation.
laser_averaged_integrations	The laser_averaged_integrations element indicates
	the number of laser integrations that are averaged.
	A value of 1 means that the integrations are not
	averaged.
laser_integrations_saturated	The laser_integrations_saturated element lists the
	number of spectra with at least one peak that
	saturates the spectrometer.
laser_power_for_calibration_max	The laser_power_for_calibration_max is the
	maximum laser power, in percent, used during
	calibration.
laser_power_for_calibration_min	The laser_power_for_calibration_min is the
	minimum laser power, in percent, used during
	calibration.
	maximum laser power, in percent, used during calibration. The laser_power_for_calibration_min is the minimum laser power, in percent, used during

laser_power_sample	The laser_power_sample is the laser power, in	
	percent, utilized during sample analysis.	
laser_pulses_discarded	The laser_pulses_discarded element indicates the	
	number of laser pulses discarded.	
laser_pulses_per_integration	The laser_pulses_per_integration element	
	identifies the number of laser pulses per	
	integration. This value is 1 for single shot spectra.	
laser_pulse_rate	The laser_pulse_rate element indicates the	
	frequency of laser pulses. A laser_pulse_rate of 10	
	Hz means that the laser fires ten times per second.	
laser_wavelength	The laser_wavelength element indicates the laser	
	wavelength utilized in sample analysis.	
measurement_location_number	The measurement_location_number element	
	indicates the location number of spectra collection	
	on the target surface.	
measurement_locations_per_sample	The measurement_locations_per_sample element	
	indicates the number of measurement locations	
	per sample.	
measurement_run	The measurement_run element identifies the run	
	number of the measurement in a particular day.	

4.5 Class <speclib:Measurement_Instrument>

Measurement_Instrument is a subclass of **Measurement_Parameters**. It identifies the spectrometer that made the measurement by its Logical Identifier (LID).

The class is expressed in the label as shown below. This class has one subclass, **Internal_Reference**, which is defined in the PDS Core Dictionary.

The table below describes the components of the **Measurement_Instrument** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Measurement_Instrument Class		
Component	Description	
*instrument_name	The instrument_name attribute provides a descriptive name of	
	the instrument that made a spectral measurement.	
*Internal_Reference	The Internal_Reference class contains the following two	
	attributes that identify the instrument. Note that this class is	
	defined in the PDS core data dictionary, not the Spectral Library	
	data dictionary (i.e., it lacks the 'speclib:' prefix).	
*lid_reference	The lid_reference attribute gives the unique PDS4 Logical	
	Identifier (LID) of the instrument that made the measurement.	
*reference_type	The reference_type attribute specifies that the LID refers to an	
	instrument. The value of this attribute must be 'is_instrument'.	

4.6 Class < speclib: Ancillary_Product>

The **Ancillary_Product** class is optional. A spectral measurement may be accompanied by one or more ancillary products, which may be images of the specimen, plots of the measurement, or other types of measurements of the specimen. This class identifies an ancillary product by its Logical Identifier (LID).

The class is expressed in the label as shown below. This class has one subclass, **Internal_Reference**, which is defined in the PDS Core Dictionary.

The table below describes the components of the **Ancillary_Product** class. Asterisks (*) indicate required components. More complete definitions are in Section 5.

Ancillary_Product Class	
Component	Description
*Internal_Reference	The Internal_Reference class contains the following two
	attributes that identify the ancillary product. Note that this class
	is defined in the PDS core data dictionary, not the Spectral
	Library data dictionary (i.e., it lacks the 'speclib:' prefix).

*lid_reference	The lid_reference attribute gives the unique PDS4 Logical	
	Identifier (LID) of an ancillary product related to this product.	
*reference_type	The reference_type attribute specifies that the LID refers to an	
	ancillary product. The value of this attribute must be	
	'data_to_ancillary'.	
*ancillary_product_type	The ancillary_product_type attribute gives the type of data in	
	the ancillary product. See Section 5 for the list of allowed values.	
	Additional values may be added to the dictionary.	

5 Definitions

Complete definitions of Spectral Library classes and attributes are given here in alphabetical order.

accumulation_time (attribute)			
Definition	The duration for which a measurement was acquired. If more than one measurement is reported, this value corresponds to the total measurement time across all measurements.		
PDS4 data type	ASCII_Real		
Min/max occurences in class	0 1		
Nillable?	no		
Min/max values	0 *		

Ancillary_Product (class)		
Definition	The Ancillary_Product class identifies an ancillary measurement	
	related to a Spectral Library specimen.	
Min/max occurences in label	0	1

ancillary_product_type (attribute)			
Definition	The ancillary_product_type element provides the type of data found in an ancillary product.		
PDS4 data type	UTF8_Short_String_Collapsed		
Min/max occurences in class	1 1		
Nillable?	no		
Allowed values	Attenuated Total Reflectance Spectroscopy	IR spectroscopic technique in which placing a sample next to a high refractive index crystal causes total internal reflection resulting in an evanescent wave that samples shallow properties of the sample	
	Image	An image of the sample	
	Chemical Composition	Elemental or oxide abundances for samples	

Differential Scanning Calorimetry	Technique in which the sample is heated and temperature is monitored to evaluate exothermic and endothermic reactions that are indicative of composition
Electron Microprobe Analysis	Microprobe technique in which the sample is bombarded with electrons, with resultant X-ray emission spectra indicative of sample composition
Modal Mineralogy	Sample mineral abundances defined as weight or volume percentages
Raman Spectroscopy	Spectroscopic technique based on based on inelastic scattering of monochromatic light, usually from a laser source
Reflectance Spectroscopy	Spectroscopic technique based on measuring the spectral properties of light scattered from samples
Thermogravimetric Analysis	Technique in which sample mass is measured as its temperature is increased
Transmission Spectroscopy	Spectroscopic technique based on measuring the spectral properties of light transmitted through samples
X-ray Diffraction	X-rays diffracted by a sample as a function of incident angle are used to determine sample crystal structure
X-ray Fluorescence	Spectroscopic technique in which the sample is bombarded by high-energy X-rays or gamma rays, with fluorescent X-ray emission spectra indicative of sample composition

dark_subtraction_flag (attribute)

Definition	-	The dark_subtraction_flag element indicates if a spectrum has been dark subtracted.	
PDS4 data type	UTF8_Short_String_	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1	
Nillable?	no		
Allowed values	Υ	Yes, the spectrum was dark subtracted.	
	N	No, the spectrum was not dark subtracted.	

data_producer_name (attribute)		
Definition	The data_producer_name element provides the name of the creator of the product.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

data_provider_name (attribute)		
Definition	The data_provider_name element provides the full name of the person who submitted the product to the Spectral Library.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

emission_angle (attribute)		
Definition	The emission_angle element provides the angle between the local vertical at the intercept point and a vector from the intercept point to the sensor.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	1 1	
Nillable?	yes	
Min/max values	-90 90	

incidence_angle (attribute)	
Definition	The incidence_angle element provides the angle between the local vertical at the intercept point and a vector from the intercept point to the source.
PDS4 data type	ASCII_Real

Min/max occurences in class	1	1
Nillable?	yes	
Min/max values	-90	90

instrument_name (attribute)		
Definition	The instrument_name element provides a descriptive name of	
	the instrument that made a spectral measurement.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1 1	
Nillable?	no	
Min/max characters	1 100	
Allowed values	any	

laser_attenuation (attribute)		
Definition	The laser_attenuation element is the energy of the laser pulse used for sample ablation.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	
Nillable?	no	

laser_averaged_integrations (attribute)			
Definition	of laser integr	The laser_averaged_integrations element indicates the number of laser integrations that are averaged. A value of 1 means that the integrations are not averaged.	
PDS4 data type	ASCII_NonNe	ASCII_NonNegative_Integer	
Min/max occurences in class	0	0 1	
Nillable?	no	no	
Min/max values	1	1 *	

laser_integrations_saturated (attribute)		
Definition	The laser_integrations_saturated element lists the number of	
	spectra with at least one peak that saturates the spectrometer.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurences in class	0 1	
Nillable?	no	
Min/max values	1 *	

laser_power_for_calibration_max (attribute)		
Definition	The laser_power_for_calibration_max element lists the	
	maximum laser power, in percent, used during calibration.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	
Nillable?	no	

Min/max values	0	100
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laser_power_for_calibration_min (attribute)			
Definition	The laser_power_for_calibration_min element lists the		
	minimum laser power, in percent, used during calibration		
PDS4 data type	ASCII_Real		
Min/max occurences in class	0 1		
Nillable?	no		
Min/max values	0 100		

laser_power_sample (attribute)		
Definition	The laser_power_sample element lists the laser power, in percent, utilized during sample analysis	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	
Nillable?	no	
Min/max values	0 100	

laser_pulses_discarded (attribute	e)		
Definition		The laser_pulses_discarded element indicates the number of laser pulses discarded.	
PDS4 data type	ASCII_N	ASCII_NonNegative_Integer	
Min/max occurences in class	0	0 1	
Nillable?	no	no	
Min/max values	0	0 *	

laser_pulses_per_integration (attribute)		
Definition	The laser_pulses_per_integration element identifies the number of laser pulses per integration. This value is 1 for single shot spectra.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurences in class	0 1	
Nillable?	no	
Min/max values	0 *	

laser_pulse_rate (attribute)		
Definition	— ·	se_rate element indicates the frequency of laser r_pulse_rate of 10 Hz means that the laser fires ten ond.
PDS4 data type	ASCII_NonNe	gative_Integer
Min/max occurences in class	0	1
Nillable?	no	
Min/max values	1	*

laser_wavelength (attribute)		
Definition	The laser_wavelengin sample analysis.	gth element lists the laser wavelength utilized
PDS4 data type	ASCII_Real	
Min/max occurences in class	0	1
Nillable?	no	
Min/max values	0	*

material_common_name (attribute)			
Definition	The material_common_name element gives the specific name of the specimen material, as specifically as it is known. For example, if a specimen is pure olivine, put "Olivine". If a specimen is a mixture of kaolinite and opal, put "Kaolinite/Opal". Indicate if "Unidentified".		
PDS4 data type	UTF8_Short_String_Collapsed		
Min/max occurences in class	0	1	
Nillable?	no		
Min/max characters	1	100	
Allowed values	any		

material_origin (attribute)		
Definition	The material_origin element identifies whether the specimen is natural, synthetic, or natural/doped.	
PDS4 data type	UTF8_Short_String_Colla	apsed
Min/max occurences in class	1	1
Nillable?	no	
Allowed values	Natural	The Natural value indicates that the specimen was not made in a laboratory.
	Synthetic	The Synthetic value indicates that the specimen or some portion of a specimen_was manufactured, laboratorygenerated, or naturally occuring sample that has been significantly modified (e.g. heating irradiation). Grinding and stirring alone do not count as significantly modified.
	Natural-Doped	The Natural-Doped value indicates natural rock matrices that have been doped with metal oxides.

material_state (attribute)			
Definition	The material_state elem specimen.	The material_state element identifies the physical state of the specimen.	
PDS4 data type	UTF8_Short_String_Coll	apsed	
Min/max occurences in class	1	1	
Nillable?	no		
Allowed values	Solid	The Solid value indicates that the specimen is in the solid state.	
	Liquid	The Liquid value indicates that the specimen is in the liquid state.	
	Gas	The Gas value indicates that the specimen is in the gas state.	

material_subtype (attribute)		
Definition	for additional in	btype element provides an optional descriptor formation about the physical state of the particulate.
PDS4 data type	UTF8_Short_Str	ing_Collapsed
Min/max occurences in class	0	10
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

material_type (attribute)		
Definition	The material_type element indicates the general type of the specimen.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1
Nillable?	no	
Allowed values	Amorphous	Sample without crystalline structure or long range order, e.g., glass
	Consolidated Mixture	Sample that is cemented or otherwise aggregated into a solid mass
	Element	Sample composed of a single element such as metallic iron
	Ice	Solid sample composed of gas or liquid (e.g., water vapor or water) now in solid form

Mineral	Sample with a given composition within a defined range of compositions and that exhibits a defined crystalline structure
Organic	Sample composed of organic materials
Rock	Solid sample composed of one or more minerals
Single Particle	Sample composed of a single particle
Unconsolidated Mixture	Sample of loose or disaggregated material that is a mixture of various minerals and/or other compounds

measurement_atmosphere_composition (attribute)			
Definition	The measure	The measurement_atmosphere_composition element identifies	
	any gas(es) p	any gas(es) present in measurement environment.	
PDS4 data type	UTF8_Text_F	Preserved	
Min/max occurences in class	0	1	
Nillable?	yes		
Min/max characters	1	1000	
Allowed values	any		

measurement_atmosphere_description (attribute)			
Definition	The measurement_atmosphere_description describes the atmospheric conditions through which the data was taken.		
PDS4 data type	UTF8_Text_Preserved		
Min/max occurences in class	1	1	
Nillable?	no		
Min/max characters	1	1000	
Allowed values	any		

measurement_atmosphere_pressure (attribute)			
Definition	-	The measurement_atmosphere_pressure element provides the atmospheric pressure of the measurement environment.	
	atmospheric presst	ire of the measurement environment.	
PDS4 data type	ASCII_Real		
Min/max occurences in class	0	1	
Nillable?	yes		
Min/max values	unlimited	unlimited	
PDS4 unit type	Units_of_Pressure		

measurement_atmosphere_relative_humidity(attribute)			
Definition	The measurement_atmosphere_relative_humidity element provides the relative humidity of the measurement		
	environment.		
PDS4 data type	ASCII_Real		
Min/max occurences in class	1	1	
Nillable?	yes		
Min/max values	0	100	

measurement_atmosphere_temperature (attribute)			
Definition	The measurement_atmosphere_temperature element provides		
	the temperature of the measurement environment.		
PDS4 data type	ASCII_Real		
Min/max occurences in class	0	1	
Nillable?	yes		
Min/max values	unlimited	unlimited	
PDS4 unit type	Units_of_Temperature		

measurement_date_time (attribute)			
Definition	The measurement_date_time element identifies the date and		
	time of the observation and measurement.		
PDS4 data type	ASCII_Date_Time_YMD		
Min/max occurences in class	1 1		
Nillable?	yes		
Allowed values	Formation rule <i>yyyymmddThh:mm:ss.nnnnnnZ</i> . The value may		
	be truncated on the right as far as the year. The Z (UTC time indicator) is optional.		

measurement_geometry_type (attribute)		
Definition	The measurement_geometry_type element identifies the type of lighting and viewing geometry at which a measurement is taken.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1 1	
Nillable?	no	
Allowed values	Bidirectional	Measurement taken when light is sent in to the specimen at a narrow angular range and received over a narrow angular range.
	Directional Hemispherical	Measurement taken when light is sent in to the specimen at a certain direction and received in all directions

	(perhaps in an integrating sphere).
Hemispherical Hemispherical	Measurement taken when light is sent in to the specimen at all directions and received in all directions (perhaps in an integrating sphere).
Biconical	Measurement taken when light is sent in to the specimen at a certain direction and in a cone-like shape and received at a certain direction and in a cone-like shape.
Unknown	The measurement geometry is unknown.

Measurement_Instrument (class)	
Definition	The Measurement_Instrument class identifies which instrument made the measurement described in the
	Measurement_Parameters class.
Min/max occurences in class	1 per Measurement_Parameters class

measurement_location_number (attribute)		
Definition	The measurement_location_number element indicates the	
	location number of spectra collection on the target surface.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurences in class	0 1	
Nillable?	no	
Min/max values	1 *	

measurement_locations_per_sample (attribute)			
Definition	The measu	The measurement_locations_per_sample element indicates the	
	number of	number of measurement locations per sample.	
PDS4 data type	ASCII_Non	ASCII_NonNegative_Integer	
Min/max occurences in class	0	0 1	
Nillable?	no		
Min/max values	0	*	

measurement_notes (attribute)	
Definition	The measurement_notes element contains relevant notes about how a measurement was made.
PDS4 data type	UTF8_Text_Preserved
Min/max occurences in class	0 1
Nillable?	no

Min/max characters	1	1000
Allowed values	any	

Measurement_Parameters (class)	
Definition	The Measurement_Parameters class contains attributes relevant
	to a single measurement of a specimen.
Min/max occurences in class	Value given by attribute measurement_segments

measurement_reference_standard (attribute)			
Definition	standard	The measurement_reference_standard element identifies the standard object on which observations are performed in order to calibrate a measurement.	
PDS4 data type	UTF8_Tex	UTF8_Text_Preserved	
Min/max occurences in class	0	0 1	
Nillable?	no	no	
Min/max characters	1	1000	
Allowed values	any		

measurement_requestor (attribute)			
Definition	The measurement_requestor element identifies the individual or laboratory who requested the measurement. It may occur up to two times.		
PDS4 data type	UTF8_Short_S	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	2	
Nillable?	yes		
Min/max characters	1	255	
Allowed values	any		

measurement_run (attribute)		
Definition	The measurement_run element identifies the run number of the measurement in a particular day.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurences in class	0	1
Nillable?	no	
Min/max values	1	*

measurement_segments	a (attribute)
Definition	The measurement_segments are the number of individual spectra that were combined to create the final merged spectrum. If the spectrum is not merged from multiple spectra, then the value of measurement_segments is 1.
PDS4 data type	ASCII_NonNegative_Integer

Min/max occurences in class	1	1
Nillable?	no	
Min/max values	1	Unlimited

measurement_source_description (attribute)			
Definition	The measurement_source_description element identifies the source used for the measurement such as the type of lamp, heating element, laser, or radioactive source.		
PDS4 data type	UTF8_Short_	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1	
Nillable?	no		
Min/max characters	1	255	
Allowed values	any		

measurement_type (attribute)		
Definition	The measurement_type element identifies the type of	
	spectroscopy performed on a specimen.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1
Nillable?	no	
Allowed values	Reflectance	The Reflectance value indicates reflectance spectroscopy, the study of light as a function of wavelength that has been reflected or scattered from a
	Emission	material. The Emission value indicates emission spectroscpy, which
		examines the wavelengths emitted by atoms or molecules during their transition from an excited state to a lower energy state.
	Raman	The Raman value indicates Raman spectroscopy, which determines information about a material by studying the Raman scattering of monochromatic light off the material.
	X-Ray Fluorescence	The X-Ray Fluorescence value indicates x-ray flourescence spectroscopy, which examines the emission of x-rays from a material previously

bombarded with high energy x-rays or gamma rays. X-Ray Diffraction The X-Ray Diffraction value indicates x-ray diffraction value indicates x-ray diffraction spectroscopy, which studies the diffraction patterns of x-rays scattered off a material. LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		
X-Ray Diffraction The X-Ray Diffraction value indicates x-ray diffraction spectroscopy, which studies the diffraction patterns of x-rays scattered off a material. LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		bombarded with high energy
indicates x-ray diffraction spectroscopy, which studies the diffraction patterns of x-rays scattered off a material. LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		x-rays or gamma rays.
spectroscopy, which studies the diffraction patterns of x-rays scattered off a material. LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further	X-Ray Diffraction	The X-Ray Diffraction value
the diffraction patterns of x-rays scattered off a material. LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		indicates x-ray diffraction
rays scattered off a material. LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance Attenuated total reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		spectroscopy, which studies
LIBS LIBS (Laser-Induced Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		the diffraction patterns of x-
Breakdown Spectroscopy) uses a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		rays scattered off a material.
a highly energetic laser pulse as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further	LIBS	LIBS (Laser-Induced
as its excitation source to produce emission spectra. Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		Breakdown Spectroscopy) uses
Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		a highly energetic laser pulse
Transmission The Transmission value indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		as its excitation source to
indicates transmission spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		produce emission spectra.
spectroscopy, the study of light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further	Transmission	The Transmission value
light as a function of wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		indicates transmission
wavelength that has been transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		spectroscopy, the study of
transmitted through a material. Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		light as a function of
Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		wavelength that has been
Attenuated Total Reflectance (ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		transmitted through a
(ATR) is a sampling technique used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		material.
used in conjunction with infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further	Attenuated Total Reflectance	Attenuated total reflectance
infrared spectroscopy which enables samples to be examined directly in the solid or liquid state without further		(ATR) is a sampling technique
enables samples to be examined directly in the solid or liquid state without further		used in conjunction with
examined directly in the solid or liquid state without further		infrared spectroscopy which
or liquid state without further		enables samples to be
·		examined directly in the solid
		or liquid state without further
preparation.		preparation.

microscope_objective (attribute)		
Definition	The microscope_objective is the magnification power of the objective lens by power (e.g. 4x, 10x).	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurences in class	0 1	
Nillable?	yes	

mineral_subtype (attribute)		
Definition	The mineral_subtype element provides for further subdividing of specimens identified as minerals. For example, the value could be 'Smectite' if the mineral_type is 'Phyllosilicate'. There is no enumerated list for mineral_subtype. The element may appear more than once.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	10
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

mineral_type (attribute)			
Definition	The mineral type element in	dentifies the type of mineral to	
Definition	The mineral_type element identifies the type of mineral to which the specimen belongs. The element may appear more than once.		
PDS4 data type	UTF8_Short_String_Collapse		
Min/max occurences in class	0 11 8_31101 t_3t1111g_collapse	Unlimited	
Nillable?		Offillitied	
Allowed values	no Amananta		
Allowed values	Arsenate		
	Borate		
	Carbonate		
	Chromate		
	Cyclosilicate		
	Halide		
	Hydroxide		
	Inosilicate		
	Iodate		
	Native Element	Native element or alloy	
	Neosilicate		
	Nitrate		
	Organic Compound		
	Oxide		
	Phosphate		
	Phyllosilicate		
	Sorosilicate		
	Sulfate		
	Sulfide		
	Tectosilicate		
	Unclassified	For a specimen that doesn't fit	
		into any of the categories, but	
		is still a mineral	
	Vanadate		
	variadate.		

organic_type (attribute)		
Definition	The organic_type element identifies the organic type to which the specimen belongs.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1
Nillable?	no	
Allowed values	Organic	The Organic value indicates the specimen is an organic material.
	Inorganic	The Inorganic value indicates the specimen is not an organic material.

Mixture	The Mixture value indicates
	the specimen is a mixture of
	organic and inorganic material.

phase_angle (attribute)		
Definition	The phase_angle and emission vec	element provides the angle between incidence stors.
PDS4 data type	ASCII_Real	
Min/max occurences in class	1	1
Nillable?	yes	
Min/max values	-180	180
PDS4 unit type	Units_of_Angle	

processing_description (attribut	e)	
Definition	The processing_description element provides information about how measurement(s) for a particular product were made, in addition to the information given in the Measurement Parameters class. In the case of a product created by merging multiple measurements, this element describes how the merge was done.	
PDS4 data type	UTF8_Text_Pre	served
Min/max occurences in class	0	1
Nillable?	no	
Min/max characters	1	Unlimited
Allowed values	any	

rock_subtype (attribute)		
Definition	The rock_subtype element provides for further subdividing of specimens identified as rocks. For example, the value could be 'Sandstone' if the rock_type is 'Sedimentary'. There is no enumerated list for rock_subtype. The element may appear more than once.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0 10	
Nillable?	no	
Min/max characters	1 255	
Allowed values	any	

rock_type (attribute)		
Definition	The rock_type element identifies the type of rock the specimen	
	is.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0 1	
Nillable?	no	

Allowed values	Igneous	The Igneous value indicates that the specimen is volatile-poor and was formed by the cooling of magma or lava.
	Sedimentary	The Sedimentary value indicates that the specimen was formed by sedimentary processes (e.g., lithification of unconsolidated material, direct chemical precipitation).
	Metamorphic	The Metamorphic value indicates that the specimen was formed by metamorphic processes (e.g., increased temperature and/or pressure conditions that altered the rock composition without melting)
	Unknown	The Unknown value indicates that there is not enough information about the specimen to assign it a rock type

segment_number (attribute)		
Definition	The segment_number element identifies which segment of a merged spectrum is described by a Measurement_Parameters class. The first segment is segment number 1. If the spectrum is not merged from multiple segments, then the value of segment_number is 1.	
PDS4 data type	ASCII_NonNegative_Integer	
Min/max occurences in class	1	1
Nillable?	no	
Min/max values	1	Unlimited

source_specimen_id (attribute)			
Definition	The source_specimen_id element identifies the source specimen		
	from which the observed specimen is derived, if any.		
PDS4 data type	UTF8_Short_String_Collapsed		
Min/max occurences in class	0	1	
Nillable?	yes		
Min/max characters	1	255	
Allowed values	any specimen_id value		

Specimen_Classification (class)

Definition	The Specimen_Classification Class provides information about how a specimen has been classified by its composition and physical state.	
Min/max occurences in class	1	1

specimen_collection_location (attribute)			
Definition	•	The specimen_collection_location element provides the place where the specimen was collected.	
PDS4 data type	UTF8_Shor	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1	
Nillable?	yes		
Min/max characters	1	255	
Allowed values	any		

specimen_description (attribute)				
Definition	The specimen_description element provides an optional short description of the specimen.			
PDS4 data type	UTF8_Text_Preserv	UTF8_Text_Preserved		
Min/max occurences in class	0	1		
Nillable?	no			
Min/max characters	1	1000		
Allowed values	any			

specimen_dilution_method (attribute)			
Definition		The specimen_dilution_method element describes the method by which dilution was conducted.	
PDS4 data type	UTF8_Text_Pr	UTF8_Text_Preserved	
Min/max occurences in class	0	1	
Nillable?	no		
Min/max characters	1	1000	
Allowed values	any		

specimen_id (attribute)		
Definition	The specimen_id element uniquely identifies the specimen within the Spectral Library. Note that this identifier is not a PDS LID (Logical Identifier), as specimens are not PDS products.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_max_size (attribute)

Definition	The specimen_max_size element identifies the maximum particle size of the observed specimen.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0	1
Nillable?	no	
Min/max values	0	Unlimited
PDS4 unit type	Units_of_Length	

specimen_max_size_reported_percentile (attribute)		
Definition	The specimen_max_size_reported_percentile specifies the percentile reported by the specimen_max_size element. For example, a specimen_max_size_reported_percentile of 90 indicates that 90 percent of the specimen has a particle size less than or equal to specimen_max_size.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	
Nillable?	no	
Min/max values	0 100	
PDS4 unit type	Units_of_None	
Specified Unit ID	Percent	

specimen_min_size (attribute)		
Definition	The specimen_max_size element identifies the minimum particle size of the observed specimen.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0	1
Nillable?	no	
Min/max values	0	Unlimited
PDS4 unit type	Units_of_Length	

specimen_min_size_reported_percentile (attribute)		
Definition	The specimen_min_size_reported_percentile specifies the percentile reported by the specimen_min_size element. For example, a specimen_min_size_reported_percentile of 90 indicates that 90 percent of the specimen has a particle size greater than or equal to specimen_min_size.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	
Nillable?	no	
Min/max values	0 100	
PDS4 unit type	Units_of_None	
Specified Unit ID	Percent	

specimen_name (attribute)		
Definition	The specimen_name element identifies the specimen as it is named where it is being kept.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_owner_location (attribute)			
Definition	The specin	The specimen_owner_location element provides the institution	
	or laborate	or laboratory name where the specimen resides.	
PDS4 data type	UTF8_Sho	UTF8_Short_String_Collapsed	
Min/max occurences in class	1	1	
Nillable?	yes		
Min/max characters	1	255	
Allowed values	any		

specimen_owner_name (attribute)			
Definition	The specimen_owner_name ele	The specimen_owner_name element identifies the individual or	
	laboratory to whom the specimen belongs.		
PDS4 data type	UTF8_Short_String_Collapsed		
Min/max occurences in class	1	1	
Nillable?	yes		
Min/max characters	1	255	
Allowed values	any		

Specimen_Parameters (class)		
Definition	The Specimen_Parameters class page specimen for which measuremen	
Min/max occurences in class	1	1

specimen_ph (attribute)	
Definition	The specimen_ph element provides the pH of the observed specimen.
PDS4 data type	ASCII_Real
Min/max occurences in class	0 1
Nillable?	no
Allowed values	0 - 14

specimen_provider_name (attribute)

Definition	The specimen_provider_name element gives the name of the person who provided the specimen for spectral measurement.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

specimen_solute_standard (attribute)			
Definition	The specimen_solute_standard element provides the standard used for the solute.		
PDS4 data type	UTF8_Short_String_Collapsed		
Min/max occurences in class	0	1	
Nillable?	no		
Min/max characters	1	255	
Allowed values	any		

specimen_thin_section_flag (attribute)			
Definition	The specimen_thin_section_flag element indicates whether or not the specimen is a thin section.		
PDS4 data type	UTF8_Short_String_Collapsed	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1	
Nillable?	no		
Allowed values	Υ	Yes, the specimen is a thin section.	
	N	No, the specimen is not a thin section.	

specimen_type (attribute)		
Definition	The specimen_type element gives one or more terms that classify the origin of the specimen. The most common combination of two specimen_types would include synthetic sample for naturally occuring specimen that have been significantly modified.	
PDS4 data type	UTF8_Short_String_Collapsed	1
Min/max occurences in class	1 2	
Nillable?	no	
Allowed values	Terrestrial Sample	The Terrestrial value means the specimen is a terrestrial sample originating on Earth.
	Lunar Meteorite	The Lunar Meteorite value means the specimen is a sample from a lunar meteorite.

Mars Meteorite	The Mars Meteorite value
	means the specimen is a
	sample from a Mars meteorite.
Other Meteorite	The Other Meteorite value
	means the specimen is a
	sample from a meteorite that
	is not a lunar or Mars
	meteorite.
Returned Lunar Sample	The Returned Lunar Sample value means the specimen is a lunar sample returned by a mission.
Returned Asteroid Sample	The Returned Asteroid Sample
	value means the specimen is
	an asteroid sample returned
	by a mission.
Synthetic Sample	The Synthetic Sample value
	means the specimen is
	manufactured, laboratory-
	generated, or a naturally
	occurring sample that has
	been significantly modified
	(e.g. heating, irradiation).
	Grinding and stirring alone do
	not count as significantly
	modified.

Spectral_Library_Product (class)		
Definition	The Spectral_Library_Product cla	ss provides information about a
	data product in the Spectral Libra	ary.
Min/max occurences in class	1	1

spectral_range_max (attribute)	
Definition	The spectral_range_max element identifies the maximum value at which a given data item was sampled. For example, a spectrum that was measured in the 0.4 to 3.5 um spectral range would have a spectral_range_max value of 3.5.
PDS4 data type	ASCII_Real
Min/max occurences in class	1 1
Nillable?	no
Min/max values	0 Unlimited

spectral_range_min (attribute)	
Definition	The spectral_range_min element identifies the minimum value
	at which a given data item was sampled. For example, a

	spectrum that was measured in the 0.4 to 3.5 um spectral range would have a spectral_range_min value of 0.4.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	1 1	
Nillable?	no	
Min/max values	0	Unlimited

spectral_range_parameter_nan			
Definition	name of the parameter	The spectral_range_parameter_name element identifies the name of the parameter which determines the sampling interval	
	of the measurement.		
PDS4 data type	UTF8_Short_String_Col	lapsed	
Min/max occurences in class	1	1	
Nillable?	no		
Allowed values	Wavelength	The spectrum is a function of wavelength.	
	Frequency	The spectrum is a function of frequency.	
	Wavenumber	The spectrum is a function of wavenumber.	
	Time	The spectrum is a function of time.	
	Angle	The spectrum is a function of angle.	
	Energy	The spectrum is a function of energy.	

spectral_range_unit_name (attribute)		
Definition	The spectral_range_unit_name element identifies the unit of measure for the values specified by spectral_range_min and spectral_range_max.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	1 1	
Nillable?	no	
Min/max characters	1	255
Allowed values	any	

spectral_resolution_width_max (attribute)		
Definition	The spectral_resolution_width_max element identifies the full width at half maximum (FWHM) of a spectral band in a given spectrum. If all bands are the same width, spectral_resolution_width_min and spectral_resolution_width_max will have the same value.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	

Nillable?	yes	
Min/max values	0	Unlimited

spectral_resolution_width_min (attribute)			
Definition	width at half r spectrum. If a spectral_reso	The spectral_resolution_width_min element identifies the full width at half minimum (FWHM) of a spectral band in a given spectrum. If all bands are the same width, spectral_resolution_width_min and spectral_resolution_width_max will have the same value.	
PDS4 data type	ASCII_Real		
Min/max occurences in class	0	1	
Nillable?	yes		
Min/max values	0	Unlimited	

spectral_resolution_width_unit (attribute)			
Definition	The spect	The spectral_resolution_width_unit element identifies the unit	
	of measur	e for the values specified by	
	spectral_r	esolution_width_min and	
	spectral_r	spectral_resolution_width_max.	
PDS4 data type	UTF8_Sho	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	0 1	
Nillable?	yes		
Min/max characters	1	255	
Allowed values	any		

spectral_sampling_interval_max	(attribute)		
Definition	maximum of all band center spectral_sa	The spectral_sampling_interval_max element identifies the maximum distance between band centers in a given spectrum. If all band centers are equally spaced, spectral_sampling_interval_min and spectral_sampling_interval_max will have the same value.	
PDS4 data type	ASCII_Real		
Min/max occurences in class	0	1	
Nillable?	yes		
Min/max values	0	Unlimited	

spectral_sampling_interval_min (attribute)		
Definition	The spectral_sampling_interval_min element identifies the minimum distance between band centers in a given spectrum. If all band centers are equally spaced, spectral_sampling_interval_min and spectral_sampling_interval_max will have the same value.	
PDS4 data type	ASCII_Real	
Min/max occurences in class	0 1	

Nillable?	yes	
Min/max values	0	Unlimited

spectral_sampling_interval_unit (attribute)		
Definition	The spectral_sampling_interval_unit element identifies the unit of measure for the values specified by	
	spectral_sampling_interval_min and	
	spectral_sampling_interval_max.	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0 1	
Nillable?	yes	
Min/max characters	1 255	
Allowed values	any	

synthetic_processing_description (attribute)			
Definition	•	The synthetic_processing_description element describes how a synthetic specimen has been processed.	
PDS4 data type	UTF8_Short	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	0 1	
Nillable?	no		
Min/max characters	1	255	
Allowed values	any		

synthetic_type (attribute)			
Definition	The synthetic_type element identifies the process by which the specimen was produced synthetically.		
PDS4 data type	UTF8_Short_String_Collapsed		
Min/max occurences in class	0 1		
Nillable?	no		
Allowed values	Entirely Synthetic	The sample is entirely human- made. If a mixture, no component in the mixture was natural.	
	Natural and Synthetic	The sample is a mixture of human-made and naturally occurring components.	
	From Natural	A natural product chemically or mineralogically altered by a laboratory treatment (e.g., heating). Does <u>not</u> include size and magnetic separates of natural samples or washing by water.	
	Hardware	Portions of an instrument, e.g., portions of a spectrometer	

that contribute to a
spectroscopic signature and
thus need to be characterized.

volatile_type (attribute)		
Definition	The volatile_type element indicates whether the material was volatile-poor (less than 2.0% loss on ignition) or volatile-rich (greater than 2.0% loss on ignition).	
PDS4 data type	UTF8_Short_String_Collapsed	
Min/max occurences in class	0	1
Nillable?	yes	
Allowed values	Poor	The Poor value indicates the specimen had less than 2.0% loss on ignition (LOI).
	Rich	The Rich value indicates the specimen had greater than 2.0% loss on ignition (LOI).
	Unknown	The Unknown value indicates the specimen's volatile type is unknown.

6 Example

The example below shows the Spectral Library part of a label for an actual product, with attribute and class names in blue text, attribute values in black text, and attribute qualifiers in orange and brown.

```
<?xml version="1.0" encoding="UTF-8"?>
<?xml-model . . . ?>
<?xml-model . . . ?>
<Product Observational . . . >
 <Identification_Area>
 </Identification Area>
 <Observation Area>
    . . .
    <Discipline Area>
       <speclib:Spectral_Library_Product>
           <speclib:Specimen Parameters>
               <speclib:specimen id>RM-REM-137/speclib:specimen id>
               <speclib:specimen name>
                    Hisingerite 70080 Gillinge <45 um/speclib:specimen_name>
               <speclib:specimen_description>
                    Silicate (Phyllo) , Hisingerite, Vis-NIR and XRD study
                    of clay minerals on Mars (MDAP)
               </speclib:specimen description>
               <speclib:specimen_min_size unit="micrometer">
                    0</speclib:specimen_min_size>
               <speclib:specimen_max_size unit="micrometer">
                    45</speclib:specimen_max_size>
```

```
<speclib:specimen collection location>
        Gillinge, Sweden</speclib:specimen collection location>
    <speclib:specimen owner location>
        Brown University</speclib:specimen owner location>
    <speclib:specimen owner name xsi:nil="true" nilReason="unknown"/>
</speclib:Specimen Parameters>
<speclib:Specimen Classification>
    <speclib:specimen_type>Terrestrial Sample
    <speclib:material origin>Natural</speclib:material origin>
    <speclib:material state>Solid</speclib:material state>
    <speclib:organic type>Inorganic/speclib:organic type>
    <speclib:material type>Mineral</speclib:material type>
    <speclib:material subtype>Particulate</speclib:material subtype>
    <speclib:material subtype>
        Particulate Ground Sorted</speclib:material subtype>
    <speclib:mineral type>Phyllosilicate</speclib:mineral type>
</speclib:Specimen Classification>
<speclib:measurement segments>1</speclib:measurement segments>
<speclib:Measurement Parameters>
    <speclib:segment_number>1</speclib:segment_number>
    <speclib:Measurement Instrument>
       <speclib:instrument name>
            RELAB Bidirectional Spectrometer</speclib:instrument name>
       <Internal Reference>
           d reference>
                urn:nasa:pds:context:instrument:facility.bd-vnir.relab
           </lid reference>
           <reference type>is instrument</reference type>
       </Internal Reference>
    </speclib:Measurement Instrument>
    <speclib:measurement type>Reflectance</speclib:measurement type>
    <speclib:spectral_range_parameter_name>
       Wavelength</speclib:spectral range parameter name>
    <speclib:spectral range min>300</speclib:spectral range min>
    <speclib:spectral range max>2600</speclib:spectral range max>
    <speclib:spectral range unit name>nm</speclib:spectral range unit name>
    <speclib:measurement geometry type>
       Bidirectional</speclib:measurement geometry type>
    <speclib:incidence angle unit="deg">30</speclib:incidence angle>
    <speclib:emission angle unit="deg">30</speclib:emission angle>
    <speclib:phase angle unit="deg">30</speclib:phase angle>
    <speclib:measurement atmosphere relative humidity xsi:nil="true"</pre>
        nilReason="unknown"/>
    <speclib:measurement atmosphere description>
       Ambient</speclib:measurement atmosphere description>
    <speclib:measurement date time>
       2012-12-14</speclib:measurement date time>
    <speclib:data producer name>RELAB</speclib:data producer name>
    <speclib:data provider name>RELAB</speclib:data provider name>
    <speclib:measurement requestor>REM</speclib:measurement requestor>
    <speclib:measurement requestor>RM</speclib:measurement requestor>
</speclib:Measurement Parameters>
<speclib:Ancillary Product>
    <Internal Reference>
       d reference>
          urn:nasa:pds:relab:data ancillary image:RM-REM-137 On9mmDish
       </lid reference>
        <reference type>data to ancillary</reference type>
```